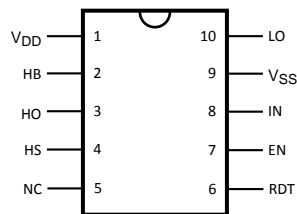


Connection Diagram



**Figure 1. 10-Lead WSON
See DPR0010A Package**



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings⁽¹⁾⁽²⁾

V_{DD} to V_{SS}	–0.3V to +18V
HB to HS	–0.3V to +18V
IN and EN to V_{SS}	–0.3V to $V_{DD} + 0.3V$
LO to V_{SS}	–0.3V to $V_{DD} + 0.3V$
HO to V_{SS}	HS – 0.3V to HB + 0.3V
HS to V_{SS} ⁽³⁾	–5V to +100V
HB to V_{SS}	118V
RDT to V_{SS}	–0.3V to 5V
Junction Temperature	+150°C
Storage Temperature Range	–55°C to +150°C
ESD Rating HBM ⁽⁴⁾	2 kV

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the component may occur. Operating Ratings are conditions under which operation of the device is guaranteed. Operating Ratings do not imply guaranteed performance limits. For guaranteed performance limits and associated test conditions, see the [Electrical Characteristics](#).
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.
- (3) In the application the HS node is clamped by the body diode of the external lower N-MOSFET, therefore the HS voltage will generally not exceed -1V. However in some applications, board resistance and inductance may result in the HS node exceeding this stated voltage transiently. If negative transients occur on HS, the HS voltage must never be more negative than $V_{DD} - 15V$. For example, if $V_{DD} = 10V$, the negative transients at HS must not exceed -5V.
- (4) The human body model is a 100 pF capacitor discharged through a 1.5kΩ resistor into each pin. Pin 2, Pin 3 and Pin 4 are rated at 500V.

Recommended Operating Conditions

V_{DD}	+8V to +14V
HS ⁽¹⁾	–1V to 100V
HB	HS + 8V to HS + 14V
HS Slew Rate	<50V/ns
Junction Temperature	–40°C to +125°C

- (1) In the application the HS node is clamped by the body diode of the external lower N-MOSFET, therefore the HS voltage will generally not exceed -1V. However in some applications, board resistance and inductance may result in the HS node exceeding this stated voltage transiently. If negative transients occur on HS, the HS voltage must never be more negative than $V_{DD} - 15V$. For example, if $V_{DD} = 10V$, the negative transients at HS must not exceed -5V.

Electrical Characteristics

Specifications in standard typeface are for $T_J = +25^{\circ}\text{C}$, and those in **boldface type** apply over the full **operating junction temperature range**. Unless otherwise specified, $V_{DD} = \text{HB} = 12\text{V}$, $V_{SS} = \text{HS} = 0\text{V}$, $\text{EN} = 5\text{V}$. No load on LO or HO. $\text{RDT} = 100\text{k}\Omega^{(1)}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
SUPPLY CURRENTS						
I_{DD}	V_{DD} Quiescent Current	$\text{IN} = \text{EN} = 0\text{V}$		0.34	0.6	mA
I_{DDO}	V_{DD} Operating Current	$f = 500\text{ kHz}$		1.65	3	mA
I_{HB}	Total HB Quiescent Current	$\text{IN} = \text{EN} = 0\text{V}$		0.06	0.2	mA
I_{HBO}	Total HB Operating Current	$f = 500\text{ kHz}$		1.3	3	mA
I_{HBS}	HB to V_{SS} Current, Quiescent	$\text{HS} = \text{HB} = 100\text{V}$		0.05	10	μA
I_{HBSO}	HB to V_{SS} Current, Operating	$f = 500\text{ kHz}$		0.1		mA
INPUT IN and EN						
V_{IL}	Low Level Input Voltage Threshold		0.8	1.8		V
V_{IH}	High Level Input Voltage Threshold			1.8	2.2	V
R_{pd}	Input Pulldown Resistance Pin IN and EN		100	200	500	$\text{k}\Omega$
DEAD-TIME CONTROLS						
VRDT	Nominal Voltage at RDT		2.7	3	3.3	V
IRDT	RDT Pin Current Limit	$\text{RDT} = 0\text{V}$	0.75	1.5	2.25	mA
UNDER VOLTAGE PROTECTION						
V_{DDR}	V_{DD} Rising Threshold		6.0	6.9	7.4	V
V_{DDH}	V_{DD} Threshold Hysteresis			0.5		V
V_{HBR}	HB Rising Threshold		5.7	6.6	7.1	V
V_{HBH}	HB Threshold Hysteresis			0.4		V
BOOT STRAP DIODE						
V_{DL}	Low-Current Forward Voltage	$I_{VDD-HB} = 100\text{ }\mu\text{A}$		0.6	0.9	V
V_{DH}	High-Current Forward Voltage	$I_{VDD-HB} = 100\text{ mA}$		0.85	1.1	V
R_D	Dynamic Resistance	$I_{VDD-HB} = 100\text{ mA}$		0.8	1.5	Ω
LO GATE DRIVER						
V_{OLL}	Low-Level Output Voltage	$I_{LO} = 100\text{ mA}$		0.25	0.4	V
V_{OHL}	High-Level Output Voltage	$I_{LO} = -100\text{ mA}$, $V_{OHL} = V_{DD} - V_{LO}$		0.35	0.55	V
I_{OHL}	Peak Pullup Current	$\text{LO} = 0\text{V}$		1.8		A
I_{OLL}	Peak Pulldown Current	$\text{LO} = 12\text{V}$		1.6		A
HO GATE DRIVER						
V_{OLH}	Low-Level Output Voltage	$I_{HO} = 100\text{ mA}$		0.25	0.4	V
V_{OHH}	High-Level Output Voltage	$I_{HO} = -100\text{ mA}$, $V_{OHH} = \text{HB} - \text{HO}$		0.35	0.55	V
I_{OHH}	Peak Pullup Current	$\text{HO} = 0\text{V}$		1.8		A
I_{OLH}	Peak Pulldown Current	$\text{HO} = 12\text{V}$		1.6		A
THERMAL RESISTANCE						
θ_{JA}	Junction to Ambient	See ⁽²⁾⁽³⁾		40		$^{\circ}\text{C/W}$

- (1) Min and Max limits are 100% production tested at 25°C . Limits over the operating temperature range are guaranteed through correlation using Statistical Quality Control (SQC) methods. Limits are used to calculate National's Average Outgoing Quality Level (AOQL).
- (2) 4 layer board with Cu finished thickness 1.5/1.0/1.0/1.5 oz. Maximum die size used. 5x body length of Cu trace on PCB top. 50 x 50mm ground and power planes embedded in PCB. See Application Note AN-1187.
- (3) The θ_{JA} is not a constant for the package and depends on the printed circuit board design and the operating conditions.

Switching Characteristics

Specifications in standard typeface are for $T_J = +25^\circ\text{C}$, and those in **boldface type** apply over the full **operating junction temperature range**. Unless otherwise specified, $V_{DD} = HB = 12\text{V}$, $V_{SS} = HS = 0\text{V}$, No Load on LO or HO⁽¹⁾.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_{LPHL}	Lower Turn-Off Propagation Delay			26	56	ns
t_{HPHL}	Upper Turn-Off Propagation Delay			26	56	ns
t_{LPLH}	Lower Turn-On Propagation Delay	RDT = 100k	485	595	705	ns
t_{HPLH}	Upper Turn-On Propagation Delay	RDT = 100k	485	595	705	ns
t_{LPLH}	Lower Turn-On Propagation Delay	RDT = 10k	75	105	150	ns
t_{HPLH}	Upper Turn-On Propagation Delay	RDT = 10k	75	105	150	ns
t_{en}, t_{sd}	Enable and Shutdown propagation delay			28		ns
DT1, DT2	Dead-Time LO OFF to HO ON & HO OFF to LO ON	RDT = 100k		570		ns
		RDT = 10k		80		ns
MDT	Dead-Time Matching	RDT = 100k		50		ns
t_R, t_F	Either Output Rise/Fall Time	$C_L = 1000\text{pF}$		15		ns
t_{BS}	Bootstrap Diode Turn-On or Turn-Off Time	$I_F = 20\text{ mA}$, $I_R = 200\text{ mA}$		50		ns

- (1) Min and Max limits are 100% production tested at 25°C . Limits over the operating temperature range are guaranteed through correlation using Statistical Quality Control (SQC) methods. Limits are used to calculate National's Average Outgoing Quality Level (AOQL).

Typical Performance Characteristics

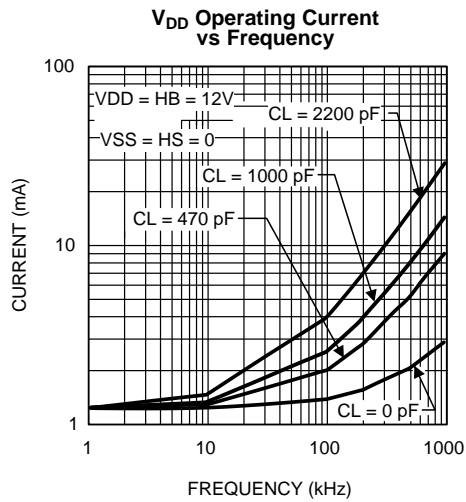


Figure 2.

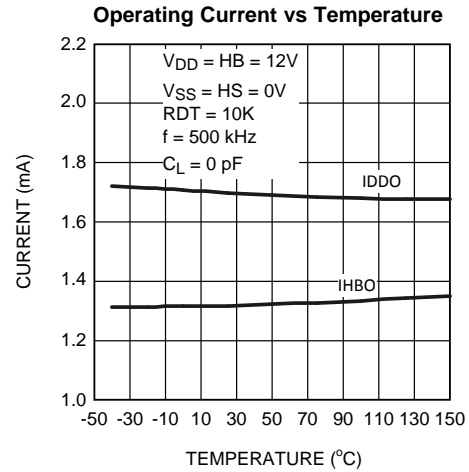


Figure 3.

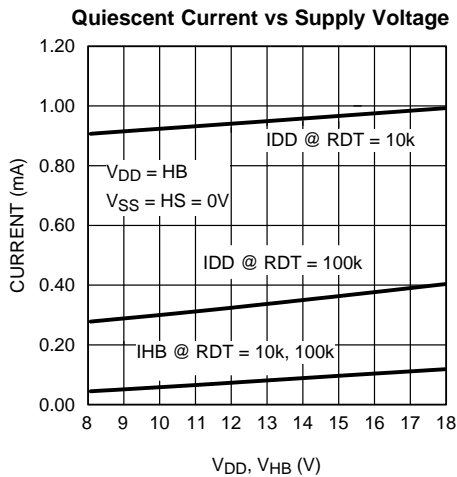


Figure 4.

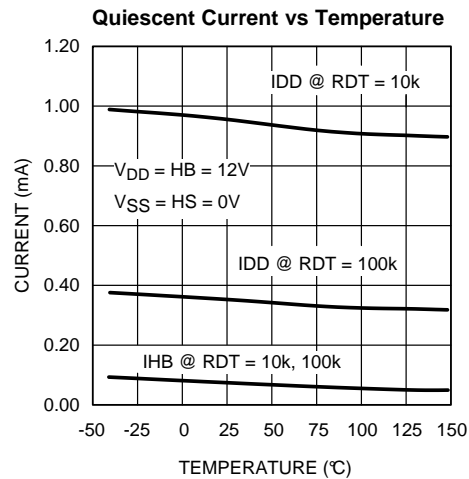


Figure 5.

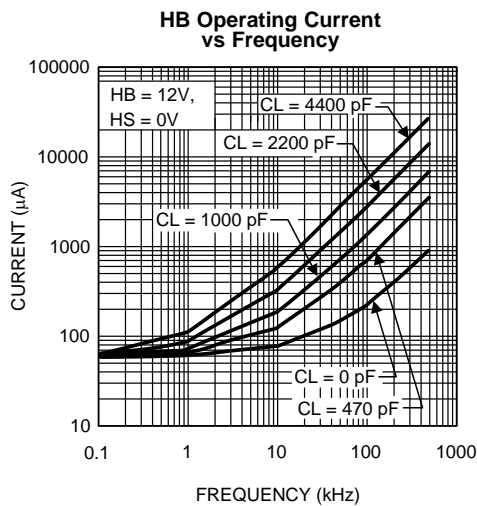


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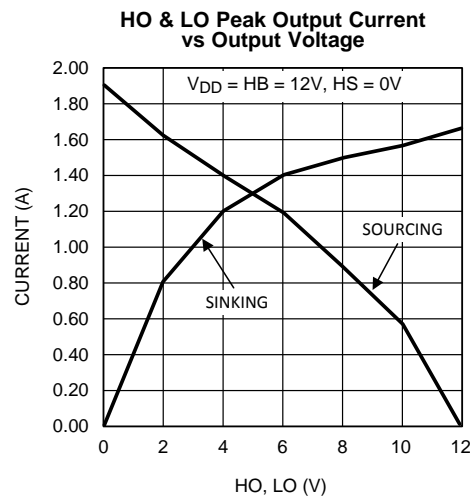


Figure 7.

Typical Performance Characteristics (continued)

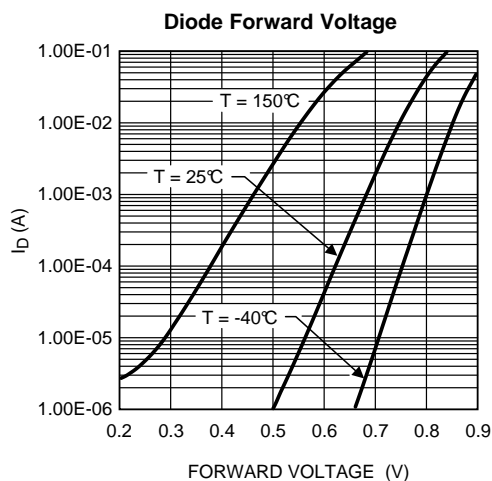


Figure 8.

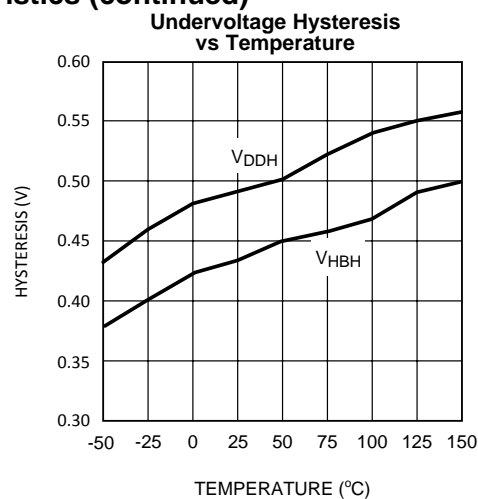


Figure 9.

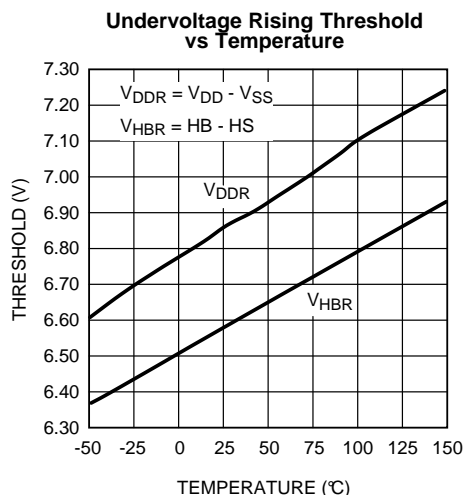


Figure 10.

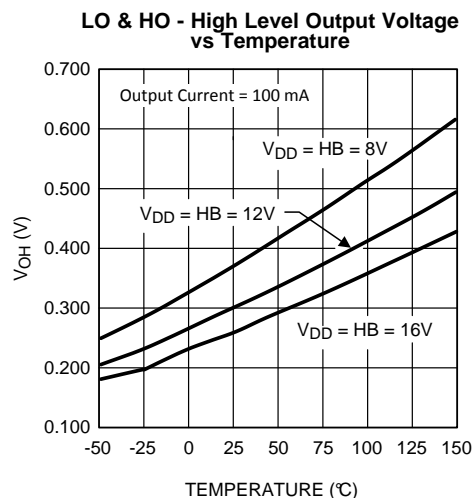


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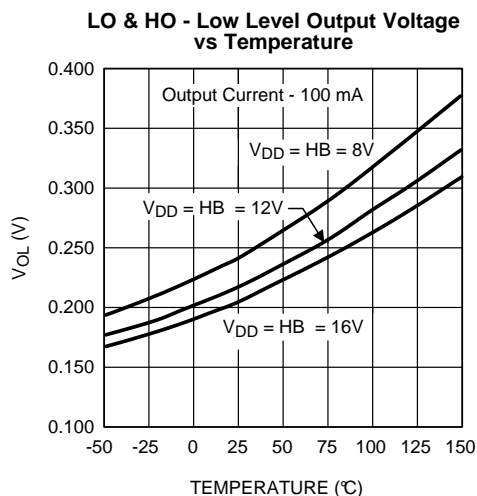


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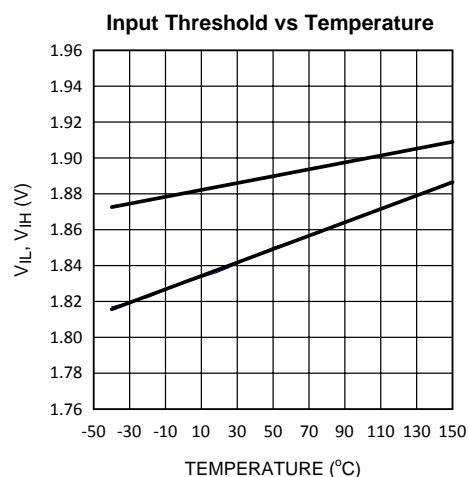


Figure 13.

Typical Performance Characteristics (continued)

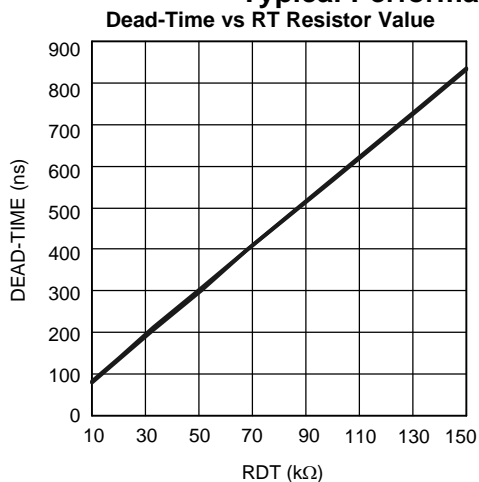


Figure 14.

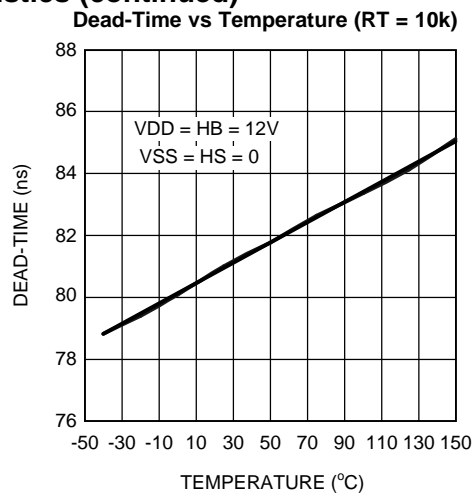


Figure 15.

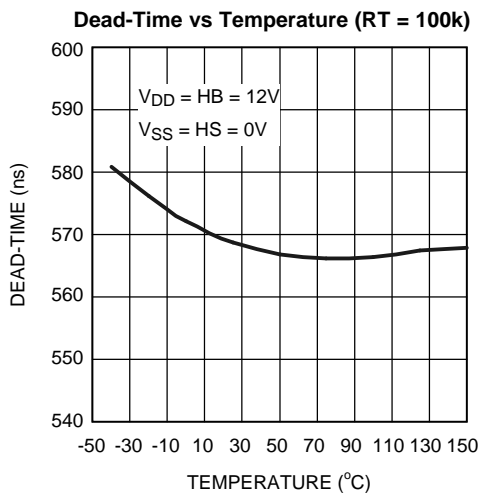


Figure 16.

Timing Diagrams

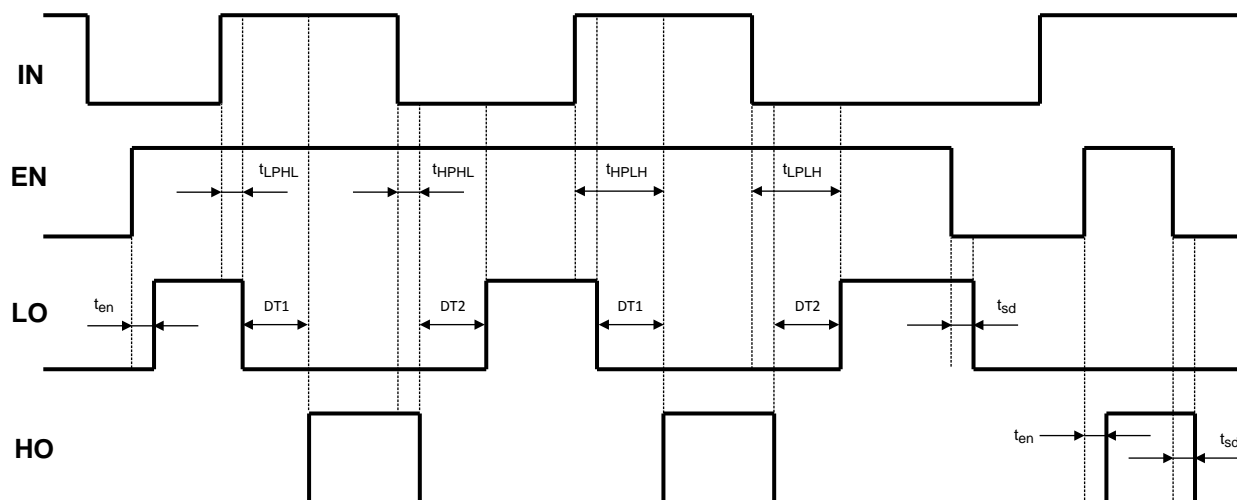


Figure 17. LM5105 Input - Output Waveforms

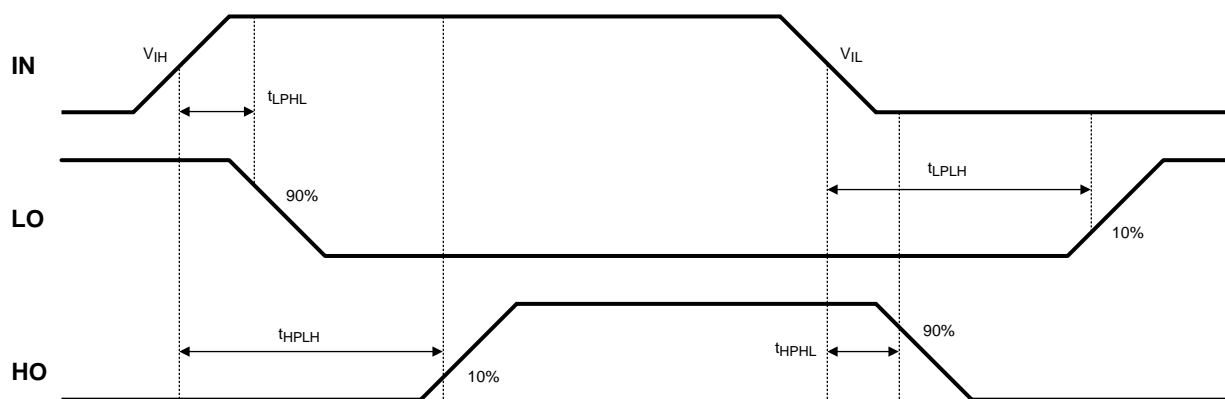
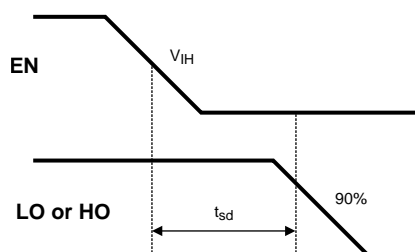
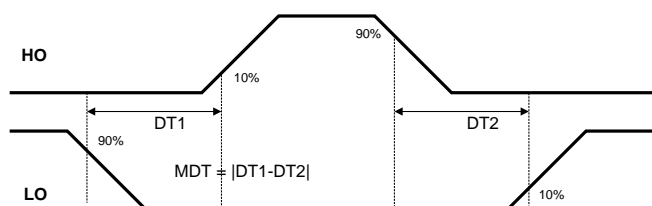
Figure 18. LM5105 Switching Time Definitions: t_{LPLH} , t_{LPHL} , t_{HPLH} , t_{HPHL} Figure 19. LM5105 Enable: t_{sd} 

Figure 20. LM5105 Dead-Time: DT

Operational Notes

The LM5105 is a single PWM input Gate Driver with Enable that offers a programmable dead-time. The dead-time is set with a resistor at the RDT pin and can be adjusted from 100ns to 600ns. The wide dead-time programming range provides the flexibility to optimize drive signal timing for a wide range of MOSFETs and applications.

The RDT pin is biased at 3V and current limited to 1 mA maximum programming current. The time delay generator will accommodate resistor values from 5k to 100k with a dead-time time that is proportional to the RDT resistance. Grounding the RDT pin programs the LM5105 to drive both outputs with minimum dead-time.

STARTUP AND UVLO

Both top and bottom drivers include under-voltage lockout (UVLO) protection circuitry which monitors the supply voltage (V_{DD}) and bootstrap capacitor voltage ($HB - HS$) independently. The UVLO circuit inhibits each driver until sufficient supply voltage is available to turn-on the external MOSFETs, and the UVLO hysteresis prevents chattering during supply voltage transitions. When the supply voltage is applied to the V_{DD} pin of LM5105, the top and bottom gates are held low until V_{DD} exceeds the UVLO threshold, typically about 6.9V. Any UVLO condition on the bootstrap capacitor will disable only the high side output (HO).

LAYOUT CONSIDERATIONS

The optimum performance of high and low side gate drivers cannot be achieved without taking due considerations during circuit board layout. Following points are emphasized.

1. A low ESR/ESL capacitor must be connected close to the IC, and between V_{DD} and V_{SS} pins and between HB and HS pins to support high peak currents being drawn from V_{DD} during turn-on of the external MOSFET.
2. To prevent large voltage transients at the drain of the top MOSFET, a low ESR electrolytic capacitor must be connected between MOSFET drain and ground (V_{SS}).
3. In order to avoid large negative transients on the switch node (HS) pin, the parasitic inductances in the source of top MOSFET and in the drain of the bottom MOSFET (synchronous rectifier) must be minimized.
4. Grounding considerations:
 - The first priority in designing grounding connections is to confine the high peak currents from charging and discharging the MOSFET gate in a minimal physical area. This will decrease the loop inductance and minimize noise issues on the gate terminal of the MOSFET. The MOSFETs should be placed as close as possible to the gate driver.
 - The second high current path includes the bootstrap capacitor, the bootstrap diode, the local ground referenced bypass capacitor and low side MOSFET body diode. The bootstrap capacitor is recharged on the cycle-by-cycle basis through the bootstrap diode from the ground referenced V_{DD} bypass capacitor. The recharging occurs in a short time interval and involves high peak current. Minimizing this loop length and area on the circuit board is important to ensure reliable operation.
5. The resistor on the RDT pin must be placed very close to the IC and separated from high current paths to avoid noise coupling to the time delay generator which could disrupt timer operation.

POWER DISSIPATION CONSIDERATIONS

The total IC power dissipation is the sum of the gate driver losses and the bootstrap diode losses. The gate driver losses are related to the switching frequency (f), output load capacitance on LO and HO (C_L), and supply voltage (V_{DD}) and can be roughly calculated as:

$$P_{DGATES} = 2 \cdot f \cdot C_L \cdot V_{DD}^2 \quad (1)$$

There are some additional losses in the gate drivers due to the internal CMOS stages used to buffer the LO and HO outputs. The following plot shows the measured gate driver power dissipation versus frequency and load capacitance. At higher frequencies and load capacitance values, the power dissipation is dominated by the power losses driving the output loads and agrees well with the above equation. This plot can be used to approximate the power losses due to the gate drivers.

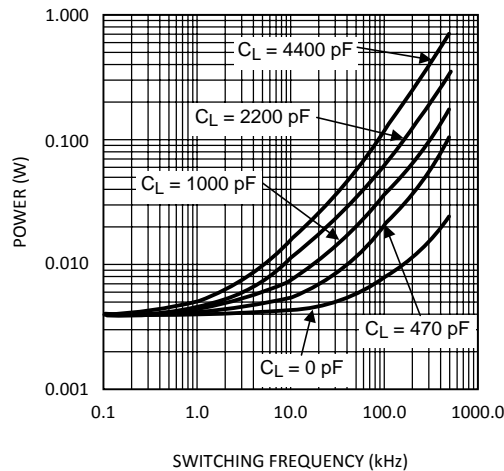


Figure 21. Gate Driver Power Dissipation (LO + HO)
 $V_{CC} = 12V$, Neglecting Diode Losses

The bootstrap diode power loss is the sum of the forward bias power loss that occurs while charging the bootstrap capacitor and the reverse bias power loss that occurs during reverse recovery. Since each of these events happens once per cycle, the diode power loss is proportional to frequency. Larger capacitive loads require more current to recharge the bootstrap capacitor resulting in more losses. Higher input voltages (V_{IN}) to the half bridge result in higher reverse recovery losses. The following plot was generated based on calculations and lab measurements of the diode recovery time and current under several operating conditions. This can be useful for approximating the diode power dissipation.

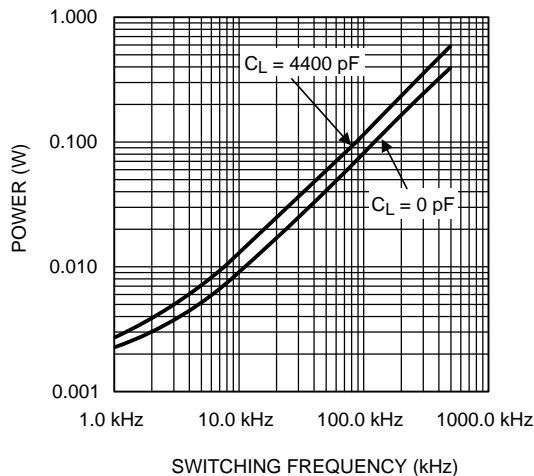


Figure 22. Diode Power Dissipation $V_{IN} = 80V$

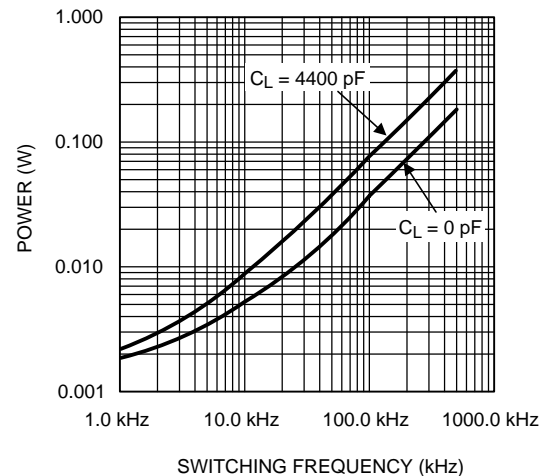


Figure 23. Diode Power Dissipation $V_{IN} = 40V$

The total IC power dissipation can be estimated from the above plots by summing the gate drive losses with the bootstrap diode losses for the intended application. Because the diode losses can be significant, an external diode placed in parallel with the internal bootstrap diode (refer to [Figure 24](#)) and can be helpful in removing power from the IC. For this to be effective, the external diode must be placed close to the IC to minimize series inductance and have a significantly lower forward voltage drop than the internal diode.

HS Transient Voltages Below Ground

The HS node will always be clamped by the body diode of the lower external FET. In some situations, board resistances and inductances can cause the HS node to transiently swing several volts below ground. The HS node can swing below ground provided:

1. HS must always be at a lower potential than HO. Pulling HO more than -0.3V below HS can activate parasitic transistors resulting in excessive current to flow from the HB supply possibly resulting in damage to the IC. The same relationship is true with LO and VSS. If necessary, a Schottky diode can be placed externally between HO and HS or LO and GND to protect the IC from this type of transient. The diode must be placed as close to the IC pins as possible in order to be effective.
2. HB to HS operating voltage should be 15V or less . Hence, if the HS pin transient voltage is -5V, VDD should be ideally limited to 10V to keep HB to HS below 15V.
3. A low ESR bypass capacitor between HB to HS as well as VCC to VSS is essential for proper operation. The capacitor should be located at the leads of the IC to minimize series inductance. The peak currents from LO and HO can be quite large. Any series inductances with the bypass capacitor will cause voltage ringing at the leads of the IC which must be avoided for reliable operation.

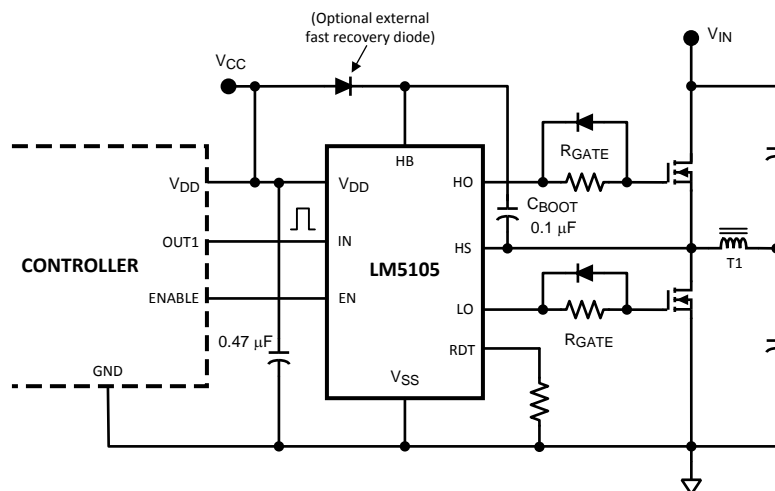


Figure 24. LM5105 Driving MOSFETs Connected in Half-Bridge Configuration

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
LM5105SD	ACTIVE	WSON	DPR	10	1000	TBD	CU SNPB	Level-1-260C-UNLIM	-40 to 125	L5105SD	Samples
LM5105SD/NOPB	ACTIVE	WSON	DPR	10	1000	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 125	L5105SD	Samples
LM5105SDX	ACTIVE	WSON	DPR	10	4500	TBD	CU SNPB	Level-1-260C-UNLIM	-40 to 125	L5105SD	Samples
LM5105SDX/NOPB	ACTIVE	WSON	DPR	10	4500	Green (RoHS & no Sb/Br)	SN	Level-1-260C-UNLIM	-40 to 125	L5105SD	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Only one of markings shown within the brackets will appear on the physical device.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

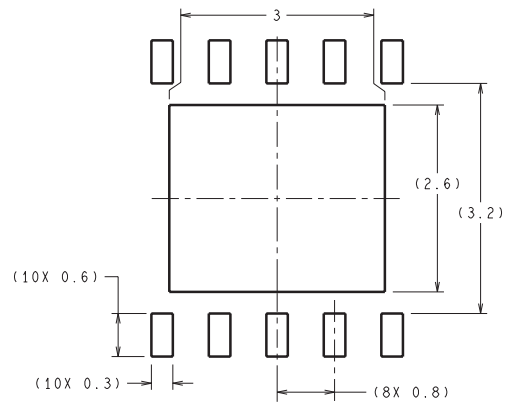
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM5105SD	WSO	DPR	10	1000	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LM5105SD/NOPB	WSO	DPR	10	1000	178.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LM5105SDX	WSO	DPR	10	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
LM5105SDX/NOPB	WSO	DPR	10	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

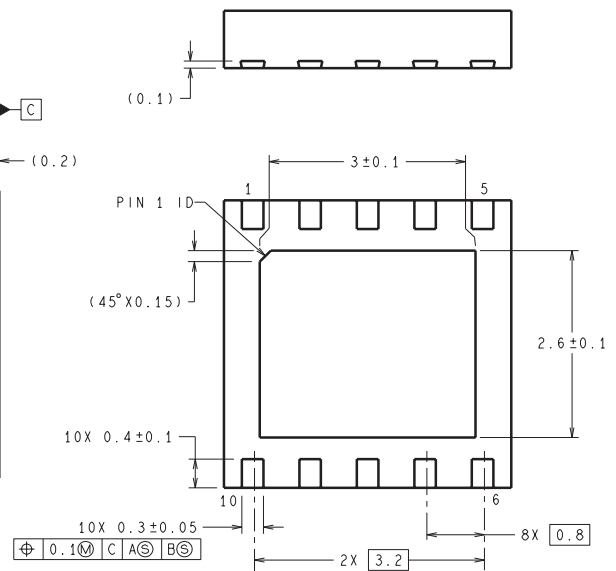
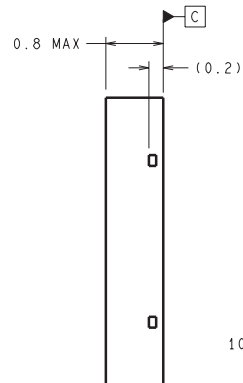
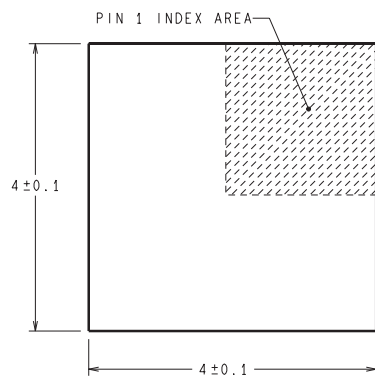


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM5105SD	WSON	DPR	10	1000	203.0	190.0	41.0
LM5105SD/NOPB	WSON	DPR	10	1000	203.0	190.0	41.0
LM5105SDX	WSON	DPR	10	4500	349.0	337.0	45.0
LM5105SDX/NOPB	WSON	DPR	10	4500	349.0	337.0	45.0



RECOMMENDED LAND PATTERN



DIMENSIONS ARE IN MILLIMETERS

SDC10A (Rev A)

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